

Vishay Siliconix

ROHS COMPLIANT

N-Channel 30-V (D-S) MOSFET

FEATURES

• 100 % R_g Tested

Halogen-free Option Available
TrenchFET[®] Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R_{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)		
30	0.047 at V _{GS} = 10 V	4.0	3.0		
	0.065 at V _{GS} = 4.5 V	3.5	5.0		

TO-236 (SOT-23) G 1 S 2 Top View

Si2306BDS (L6)*

* Marking Code

Ordering Information: Si2306BDS-T1-E3 (Lead (Pb)-free) Si2306BDS-T1-GE3 (Lead (Pb)-free and Halogen-free)

Parameter		Symbol	5 s	Steady State	Unit
Drain-Source Voltage		V _{DS}	30		V
Gate-Source Voltage		V _{GS}	± 20		
Quality Design Quarter (T = 150 20) a b	T _A = 25 °C	– I _D	4.0	3.16	٨
Continuous Drain Current (T _J = 150 °C) ^{a, b}	T _A = 70 °C		3.5	2.7	
Pulsed Drain Current		I _{DM}	20		A
Continuous Source Current (Diode Conduction) ^{a, b}		۱ _S	1.04	0.62	
	T _A = 25 °C	- P _D	1.25	0.75	14/
Maximum Power Dissipation ^{a, b}	T _A = 70 °C		0.8	0.48	W
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150		°C

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Mauinum lunction to Anchienta	t ≤ 5 s	– R _{thJA}	80	100	
Maximum Junction-to-Ambient ^a	Steady State		130	166	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	60	75	

Notes:

a. Surface Mounted on FR4 board, $t \leq 5 \mbox{ s.}$

b. Pulse width limited by maximum junction temperature.

c. Surface Mounted on FR4 board.

For SPICE model information via the Worldwide Web: http://www.vishay.com/www/product/spice.htm

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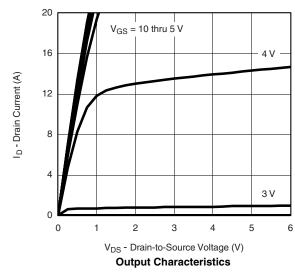
			Limits				
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_{D} = 250 \mu A$	30			V	
Gate-Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1.0		3.0		
Gate-Body Leakage	I_{GSS} $V_{DS} = 0 V, V_{GS} = \pm 20 V$				± 100	nA	
Zara Cata Valtaga Drain Currant	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			0.5		
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 ^{\circ}\text{C}$			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 4.5 \text{ V}, V_{GS} = 10 \text{ V}$	6			А	
	_	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3.5 \text{ A}$		0.038	0.047	Ω	
Drain-Source On-Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 2.8 A		0.052	0.065		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 4.5 V, I _D = 2.5 A		7.0		S	
Diode Forward Voltage	V _{SD}	I _S = 1.25 A, V _{GS} = 0 V		0.8	1.2	V	
Dynamic							
Gate Charge	Qg	$V_{DS} = 15 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 2.5 \text{ A}$		3.0	4.5	nC	
Total Gate Charge	Q _{gt}			6	9		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 2.5 \text{ A}$		1.6			
Gate-Drain Charge	Q _{gd}			0.6			
Gate Resistance	Rg	f = 1.0 MHz	2.5	5	7.5	Ω	
Input Capacitance	C _{iss}			305			
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		65		pF	
Reverse Transfer Capacitance	C _{rss}			29			
Switching							
Turn-On Delay Time	t _{d(on)}			7	11	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 15 Ω		12	18		
Turn-Off Delay Time	t _{d(off)}	${\sf I}_{\sf D}\cong$ 1 A, ${\sf V}_{\sf GEN}$ = 10 V, ${\sf R}_{\sf g}$ = 6 Ω		14	25		
Fall Time	t _f			6	10		
Reverse Recovery Time	t _{rr}	I _F = 1.25 A, di/dt = 100 A/μs		14	21		
Body Diode Reverse Recovery Charge	Q _{rr}	$r_{\rm F} = 1.25$ A, u/ul = 100 A/µS		6	10	nC	

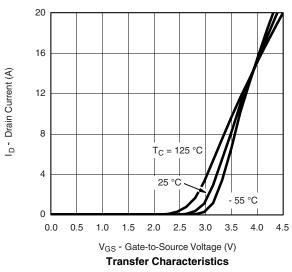
Notes:

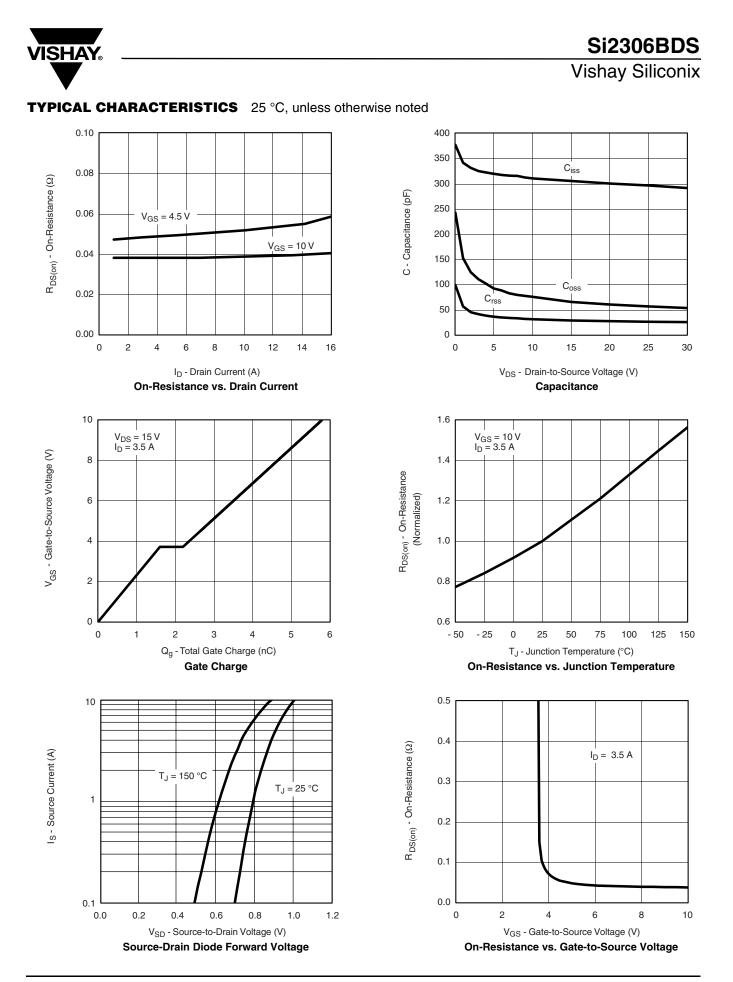
a. Pulse test: Pulse width \leq 300 µs, duty cycle \leq 2 %.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







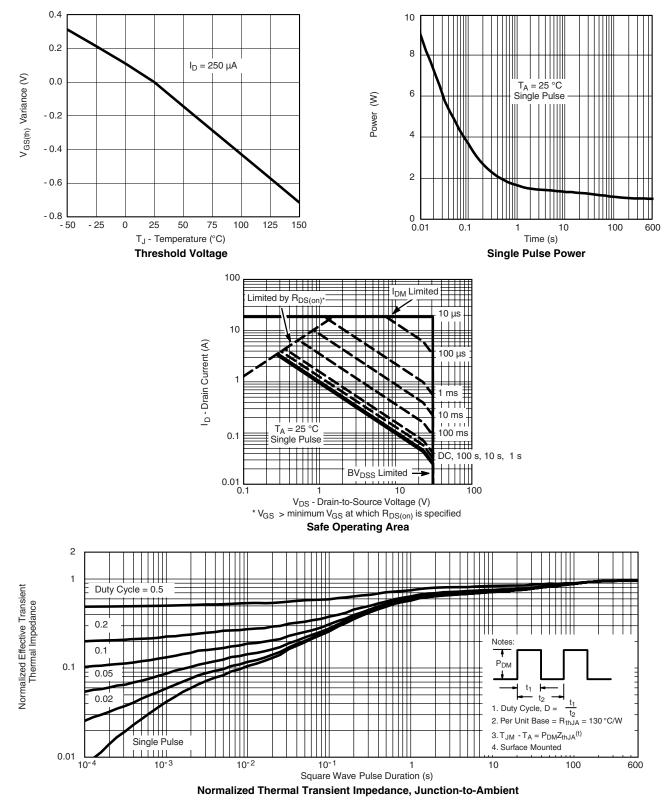
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Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?73234.



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